Global null testing Modern Inference

Aldo Solari

Outline

- **1** The p-value
- 2 Global null testing
- Maximum statistic
- **4** Sum of statistics

Deterministic proof by contradiction

- Assume a proposition, the opposite of what you think about, i.e. the opposite conclusion of your theorem
- 2 Write down a sequence of logical steps/math
- 3 Derive a contradiction
- Occide that the proposition is false (which implies that the theorem is true)

Stochastic proof by contradiction

- Set H_0 (the proposition)
- 2 Collect data (which is noisy)
- 3 Derive an apparent contradiction (i.e. if H_0 is true, then this data is very weird)
- **4** Hence we reject H_0 ; this is called a "discovery"

Hypothesis testing is stochastic because we might make errors:

Type I (false discoveries) and Type II (missed discoveries)

Theorem: There is no greatest even integer.

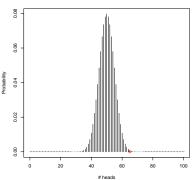
- We take the negation of the theorem and suppose it to be true: Suppose there is greatest even integer N. [We must deduce a contradiction.]
- Then, for every even integer n, $N \ge n$.
- Now suppose M = N + 2. Then, M is an even integer. [Because it is a sum of even integers.]
- Also, M > N [since M = N + 2].
- Therefore, *M* is an integer that is greater than the greatest integer.
- This contradicts the supposition that N ≥ n for every even integer n. [Hence, the supposition is false and the statement is true.]
 - And this completes the proof.

Assume we have a coin and want to determine whether or not it is fair. In this case we have

 H_0 : Coin is fair $(\theta = 1/2)$

 H_1 : Coin is biased (heta
eq 1/2)

The probability distribution of X= "the number of heads in 100 trials" under H_0 is Binomial(n=100, $\theta=1/2$). After tossing the coin n=100 times we then get x=65 heads and n-x=35 tails.



- Is this then enough to reject H_0 ?
- To determine this we calculate a *p*-value associated with our observed data assuming the null hypothesis
- A p-value is the probability of seeing what you saw or something more extreme - given that H₀ is true.
- Small p-values imply an unexpected outcome, given that the null (H₀) is true
- So if p = 0.0018 then either H_0 isn't true or we are really unlucky and saw this data

The *p*-value

- Choose a test statistic T = t(Y), large values of which cast doubts on H_0
- Observe the data y_{obs} , realization of Y

•

$$p_{\rm obs} = P_0(T \ge t_{\rm obs})$$

where $t_{\rm obs} = t(y_{obs})$ and P_0 is the probability under H_0

p-value null distribution

- $p_{\rm obs} = 1 F_0(t_{\rm obs})$, where F_0 is the null distribution function of T, supposed to be continuous and invertible.
- One interpretation of $p_{\rm obs}$ stems from the corresponding random variable $P=1-F_0(T)$
- The null distribution of P is Uniform(0,1): for any $u \in (0,1)$,

$$P_0(P \le u) = P_0(F_0^{-1}(1-u) \le T) = 1 - F_0(F_0^{-1}(1-u)) = u$$



One- and two-sided tests

- Suppose that we have a test statistic T with continuous distribution, small and large values of which indicate a departure from H₀
- Calculate

$$p_{\mathrm{obs}}^- = \mathrm{P}_0(T \leq t_{\mathrm{obs}}), \quad p_{\mathrm{obs}}^+ = \mathrm{P}_0(T \geq t_{\mathrm{obs}})$$

• The *p*-value is

$$p_{\mathrm{obs}} = 2 \min(p_{\mathrm{obs}}^-, p_{\mathrm{obs}}^+)$$

This follows because the null distribution of $Q = \min(P^-, P^+)$ is

$$Q = \min(1 - U(0,1), U(0,1)) = U(0,1/2)$$

thus the null distribution of 2Q is U(0,1)



Discrete null distribution

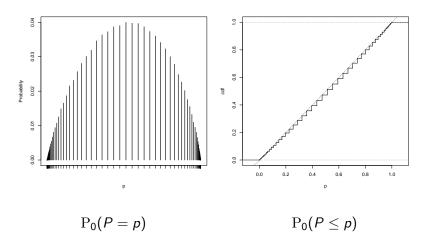
- Suppose $T \sim \text{Poisson}(\mu)$ and we observe $t_{\text{obs}} = 3$
- We want to test $H_0: \mu = 2$ vs $H_1: \mu \neq 2$

•

$$p_{\mathrm{obs}}^{+} = \mathrm{P_0}(T \geq t_{\mathrm{obs}}) = \sum_{t=t_{\mathrm{obs}}}^{\infty} \frac{\mu^t e^{-\mu}}{t!}$$

$$ho_{\mathrm{obs}}^- = \mathrm{P_0}(T \leq t_{\mathrm{obs}}) = \sum_{t=0}^{t_{\mathrm{obs}}} \frac{\mu^t e^{-\mu}}{t!}$$

With discrete null distribution, $p_{\rm obs}$ is $q_{\rm obs} = {\rm min}(p_{\rm obs}^-, p_{\rm obs}^+)$ plus the achievable p-value from the other tail of the distribution nearest to but not exceeding $q_{\rm obs}$



Example of null discrete distribution (pmf and cdf) of the p-value

Valid *p*-values

We have a *valid test* if the *p*-value is uniformly distributed under H_0 , i.e.

$$P_0(P \le u) = u \quad \forall u \in (0,1)$$

or more generally (e.g. for discrete null distributions) if the p-value is $stochastically\ dominated$ by the uniform distribution under H_0 , i.e.

$$P_0(P \le u) \le u \quad \forall u \in (0,1)$$

Outline

- 1 The p-value
- **2** Global null testing
- Maximum statistic
- **4** Sum of statistics

Inference on the mean

$$y \sim N_m(\mu, \Sigma)$$

where $y=(y_1,\ldots,y_m)^{\mathsf{T}}$ is the response, $\mu=(\mu_1,\ldots,\mu_m)^{\mathsf{T}}$ is the mean vector (where $\mu_i=0$ means "no effect" and $\mu_i\neq 0$ means "effect") and Σ is the correlation matrix. Marginally, $y_i\sim N(\mu_i,1)$

Consider the following questions:

- **①** Detecting effects: There is at least one μ_i different from 0?
- **2** Counting effects: How many μ_i are different from 0?
- **3** *Identifying effects*: Which μ_i are different from 0?

Global null

Testing the global null hypothesis aims at detecting any effect

$$H_0: \mu = 0$$
, i.e. $\mu_i = 0$ for all $i = 1, ..., m$
 $H_1: \mu \neq 0$, i.e. $\mu_i \neq 0$ for at least one i

One-sided alternative

$$H_0$$
: $\mu_i = 0$ for all $i = 1, ..., m$
 H_1 : $\mu_i > 0$ for at least one i

We will consider three different tests (one-sided alternative):

- Maximum statistic: $T_{\text{max}} = \max(y_1, \dots, y_m)$
- Sum of statistics $T_{\text{sum}} = \sum_{i=1}^{m} y_i^2$
- Higher criticism

For simplicity, assume that the y_i s are independent (i.e. $\Sigma = I_m$)

Outline

1 The p-value

- 2 Global null testing
- **3** Maximum statistic
- **4** Sum of statistics

Maximum statistic

• The critical value $t_{1-\alpha}$ of the test based on the maximum statistic is

$$P_0(T_{\max} \ge t_{1-\alpha}) = \alpha$$

where $t_{1-\alpha}$ is the $1-\alpha$ quantile of the distribution of the maximum of m independent standard normal variables

$$\int_{t_{1-\alpha}}^{\infty} m\phi(y) \Phi(y)^{m-1} dy = \alpha$$

where ϕ and Φ are the density and cdf of N(0,1)

Minimum *p*-value

• Equivalently, define $p_i = 1 - \Phi(y_i) \stackrel{H_0}{\sim} U(0,1)$ and use the minimum p-value

$$p_{\min} = \min(p_1, \ldots, p_m) \stackrel{H_0}{\sim} \operatorname{Beta}(1, m)$$

- The MinP test rejects H_0 if $p_{\min} \leq 1 (1 \alpha)^{\frac{1}{m}}$
- To see this

$$P_{0}(p_{\min} \leq 1 - (1 - \alpha)^{\frac{1}{m}}) = 1 - P_{0}\left(\bigcap_{i=1}^{m} \{p_{i} > 1 - (1 - \alpha)^{\frac{1}{m}}\}\right)$$
$$= 1 - [(1 - \alpha)^{\frac{1}{m}}]^{m} = \alpha$$

Approximated critical value

• Replace $t_{1-\alpha}$ by $z_{1-\alpha/m}$, where z_{α} is the α quantile of N(0,1)

$$P_0(T_{\max} \ge z_{1-\alpha/m}) = P_0\left(\bigcup_{i=1}^m \{y_i \ge z_{1-\alpha/m}\}\right)$$

$$\le \sum_{i=1}^m P_0(y_i \ge z_{1-\alpha/m}) = m\frac{\alpha}{m} = \alpha$$

• The union bound might seem crude, but with independent y_i s the size of the test is very near α

$$P_0(T_{\max} \ge z_{1-\alpha/m}) = 1 - \prod_{i=1}^m P_0(y_i < z_{1-\alpha/m})$$
$$= 1 - \left(1 - \frac{\alpha}{m}\right)^m \stackrel{m \to \infty}{\to} 1 - e^{-\alpha} \approx \alpha$$

For $\alpha = 0.05$, the size is 0.0487 (asymptotically)

Magnitude of the critical value

• We have

$$P(Z > t) \le \frac{\phi(t)}{t}$$

• To see this

$$\int_{t}^{\infty} \frac{1}{\sqrt{2\pi}} e^{-z^{2}/2} dz < \frac{1}{t\sqrt{2\pi}} \int_{t}^{\infty} z e^{-z^{2}/2} dz = \frac{1}{t\sqrt{2\pi}} e^{-t^{2}/2}$$

· It follows that

$$P(Z > \sqrt{2\log m}) \le \frac{\phi(\sqrt{2\log m})}{\sqrt{2\log m}} = \frac{1}{2m\sqrt{\pi\log m}} < \frac{\alpha}{m}$$

as soon as
$$\sqrt{\log m} > \frac{1}{2\sqrt{\pi}\alpha}$$

• Therefore $z_{1-\alpha/m} \leq \sqrt{2\log m}$ if $\sqrt{\log m} > \frac{1}{2\sqrt{\pi}\alpha}$

Magnitude of the critical value

- It can be proved that $(1-1/t^2)\frac{\phi(t)}{t} < \mathrm{P}(Z>t)$
- Then, for any fixed α and $\epsilon > 0$, the following inequalities hold for all large enough m:

$$\sqrt{(1-\epsilon)2\log(m)} \le z_{1-\alpha/m} \le \sqrt{2\log(m)}$$

Hence, $z_{1-\alpha/m}$ grows like $\sqrt{2 \log m}$

• For large m, the maximum test rejects H_0 when

$$T_{\max} \ge \sqrt{2 \log m}$$

and there is (asymptotically) no dependence on α

Needle in a haystack problem

$$H_0: \mu_i = 0 \text{ for all } i = 1, \dots, m$$

 $H_1: \mu_i = c > 0, \mu_j = 0 \text{ for } j \neq i$

• What is the limiting power of the test?

$$\lim_{m\to\infty} P_1(T_{\max} > z_{1-\alpha/m})$$

• The answer to this question depends on the limiting ratio

$$\lim_{m\to\infty}\frac{c}{\sqrt{2\log m}}$$

where c = c(m) is the value of the single non-zero mean, which is a function of m

Needle in a haystack problem

Two cases:

• Suppose $c > (1 + \epsilon)\sqrt{2\log m}$. Then, assuming without loss of generality that $\mu_1 = c$,

$$P_1(T_{\max} > z_{1-\alpha/m}) \ge P_1(y_1 > z_{1-\alpha/m}) = P(Z > z_{1-\alpha/m} - c) \to 1$$

• Suppose $c < (1+\epsilon)\sqrt{2\log m}$. Then

$$\begin{aligned} \mathrm{P}_{1}(T_{\mathrm{max}} > z_{1-\alpha/m}) & \leq & \mathrm{P}(y_{1} > z_{1-\alpha/m}) + \mathrm{P}(\max_{i > 1} y_{i} > z_{1-\alpha/m}) \\ & = & \mathrm{P}(Z > z_{1-\frac{\alpha}{m}} - c) + \mathrm{P}(\max_{i > 1} y_{i} > z_{1-\frac{\alpha}{m}}) \\ & \rightarrow & 0 + (1 - e^{-\alpha}) \approx \alpha \end{aligned}$$

• Can we do better than this test? No, it is asymptotically equivalent to optimal test given by Neyman-Pearson lemma

Outline

- 1 The *p*-value
- 2 Global null testing
- Maximum statistic

4 Sum of statistics

Sum of statistics

$$T_{\text{sum}} = ||y||^2 = \sum_{i=1}^m y_i^2$$

Under H₀

- $y_i^2 \stackrel{H_0}{\sim} \chi_1^2$ and $T_{\text{sum}} \stackrel{H_0}{\sim} \chi_m^2$
- CLT approximation: $Z_{\mathrm{sum}} = \frac{T_{\mathrm{sum}} m}{\sqrt{2m}} pprox \mathcal{N}(0,1)$

Under H_1

- $y_i = (Z + \mu_i)^2$ is a non-central χ_1^2 with $\mathbb{E}(y_i) = 1 + \mu_i^2$ and $\mathbb{V}\mathrm{ar}(y_i) = 2 + 4\mu_i^2$, and T_sum is a non-central χ_m^2
- CLT approximation: $rac{T_{ ext{sum}}-(m+\|\mu\|^2)}{\sqrt{2m+4\|\mu\|^2}}pprox extsf{N}(0,1)$



Dense alternative

 $H_0: \mu_i = 0$ for all i

 $H_1: \mu_i = c > 0 \text{ for all } i$

• The normalized version of the sum statistic:

$$Z_{\mathrm{sum}} \stackrel{H_0}{\sim} N(0,1) \qquad Z_{\mathrm{sum}} \stackrel{H_1}{\sim} N\Big(\theta, 1 + \frac{\theta}{\sqrt{m/8}}\Big)$$

where

$$\theta = \frac{\|\mu\|^2}{\sqrt{2m}} = \sqrt{\frac{m}{2}}c^2$$

is the signal-to-noise ratio, with c = c(m)

• If $\theta \to 0$ when $m \to \infty$, then the test has no power. We can't do better because this test is asymptotically equivalent to optimal test given by Neyman-Pearson lemma

Comparison

The two test are effective in two different regimes:

• Few strong effects:

 $m^{1/4}$ of the μ_i s are equal to $\sqrt{2\log m}$, the rest 0. E.g. when $m=10^6$, $n^{1/4}\approx 36$ and $\sqrt{2\log m}\approx 5.3$. In this setting $T_{\rm max}$ has full power, but $T_{\rm sum}$ has no power because

$$\theta = \frac{m^{1/4} 2 \log m}{\sqrt{2m}} \to 0$$

• Small, distributed effects:

 $\sqrt{2m}$ of the μ_i s are equal to 3, the rest 0.

The T_{sum} has (almost) has full power, but T_{max} has no power because when m is large it's very likely that the largest y_i value comes from a null μ_i , not a true signal. An intuitive argument is as follows: among the nulls, the largest y_i has size $\approx \sqrt{2\log m}$ while among the true signals, the largest y_i has size $\approx 3 + \sqrt{2\log\sqrt{2m}}$. If m is large, the former is larger